## ■ MN101C77 Series

Туре	MN101C77A	MN101C77C	MN101C77D	MN101C77F	MN101CF77G			
Internal ROM type		FLASH						
ROM (byte)	32K	48K	64K	96K	128K			
RAM (byte)	1.5K	3K	6K					
Package (Lead-free)	LQFP064-P-1414	LQFP064-P-1414, TQFP064-P-1010C	LQFP064-P-1414		LQFP064-P-1414, TQFP064-P-1010C			
Minimum Instruction Execution Time	[Standard] 0.1 µs (at 2.5 V to 3.6 V, 20 MHz)* 0.2 µs (at 2.1 V to 3.6 V, 10 MHz)* 0.5 µs (at 1.8 V to 3.6 V, 4 MHz)* 62.5 µs (at 1.8 V to 3.6 V, 32 kHz)* [Double speed] 0.119 µs (at 2.5 V to 3.6 V, 8.39 MHz)* *: The operation guarantee range for flash memory built-in type is 2.7 V to 3.6 V.							

#### ■ Interrupts

RESET. Watchdog. External 0 to 4. Timer 0. Timer 1. Timer 4 to 6. Timer 7 (2 systems). Time base. Serial 0 reception. Serial 0 transmission. Serial 1 reception. Serial 1 transmission. Serial 3. Serial 4. Automatic transfer finish. A/D conversion finish. Key interrupts (8 lines)

#### ■ Timer Counter

8-bit timer  $\times$  5

Timer 0 ......Square-wave/8-bit PWM output. Event count. Remote control carrier output. Pulse width measurement Timer 1 ......Square-wave output. Event count. Synchronous output event

Timer 4 ......Square-wave/8-bit PWM output. Event count. Pulse width measurement. Serial 1 baud rate timer Timer 5 ......Square-wave/8-bit PWM output. Event count. Pulse width measurement. Serial 0 baud rate timer

Timer 6 ......8-bit freerun timer Timer 0, 1 can be cascade-connected

16-bit timer  $\times$  1

Timer 7 .......Square-wave/16-bit PWM output (cycle/duty continuous variable). Event count. Synchronous output event. Pulse width measurement. Input capture

Time base timer: One-minute count setting

Watchdog timer × 1

#### ■ Serial interface

 $Synchronous\ type/UART\ (full-duplex)\times 2:\ Serial\ 0,\ 1\\ Synchronous\ type/Single-master\ I^2C\times 1:\ Serial\ 3$ 

 $I^2C$  slave  $\times$  1: Serial 4

 $Serial\ 4.....I^2C\ high-speed\ transfer\ mode.\ 7-bit/10-bit\ address\ setting.\ General\ call$ 

#### ■ DMA controller

Maximum transfer cycles: 255

Starting factor: External request. Various types of interrupt. Software

Transfer mode: 1-byte transfer. Word transfer. Burst transfer

#### ■ I/O Pins

I/O 53: Common use. Specified pull-up resistor available. Input/output selectable (bit unit)

#### ■ A/D converter

10-bit  $\times$  7 channels (with S/H)

#### D/A converter

8-bit × 2 channels (Serves as AD pin, as well)

#### ■ Special Ports

Buzzer output. Remote control carrier output. High-current drive port

#### ■ ROM Correction

Correcting address designation: Up to 3 addresses possible

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## MN101C77A, MN101C77C, MN101C77D, MN101C77F, MN101CF77G

### ■ Electrical Charactreistics (Supply current)

Parameter	Symbol	Condition	Limit			Unit
		Condition		typ	max	Offic
Operating supply current	IDD1	fosc = 20  MHz (fs = $fosc/2$ ). $VDD = 3.3  V$		6	12	mA
	IDD2	fosc = 8.39  MHz (fs = fosc/2).  VDD = 3.3  V		3	6	mA
	IDD3	fx = 32.768  kHz (fs = fx/2).  VDD = 3.3  V			40	μΑ
Supply current at HALT	IDD4	fx = 32.768 kHz. VDD = 3.3 V. Ta = 25 °C		5	10	μΑ
	IDD5	fx = 32.768 kHz. VDD = 3.3 V			40	μА
Supply current at STOP	IDD6	VDD = 3.3 V. Ta = 25 °C			2	μΑ
	IDD7	VDD = 3.3 V. Ta = 85 °C			30	μΑ

 $Ta = -40 \, ^{\circ}\text{C}$  to  $+85 \, ^{\circ}\text{C}$ .  $VDD = 1.8 \, \text{V}$  to  $3.6 \, \text{V}$ .  $VSS = 0 \, \text{V}$ 

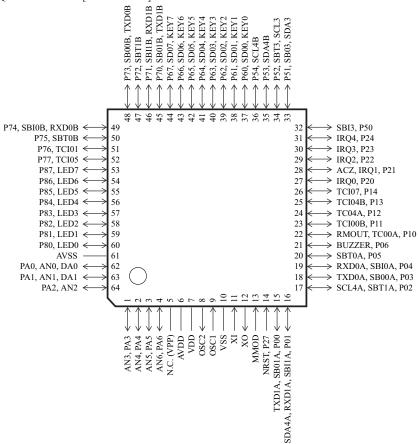
#### ■ Development tools

In-circuit Emulator

PX-ICE101C/D + PX-PRB101C77-TQFP064-P-1010C PX-ICE101C/D + PX-PRB101C77-LQFP064-P-1414

#### ■ Pin Assignment

LQFP064-P-1414, TQFP064-P-1010C [MN101C77C]



Note) Pin 5 serves as the VPP pin in the MN101CF77G, and cannot be used as a user pin.

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